Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/712,169	DEHAAN ET AL.	
Examiner	Art Unit	
Tam M. Nguyen	1764	

SEARCHED				
Class	Subclass	Date	Examiner	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
see PGPL	JP printout	3/16/2007	TN	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
east	3/16/2007	TN		
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